PTO/SB/17 (12-04v2) Approved for use through 7/31/2006. OMB 0651-0032

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Effective on 12/08/2004.		mplete if Know						
Fees pursuant to the Consolidated Appropriations Act, 2005 (H.R. 4818).	Application Number 09/612,5		12,543-Conf. #9387					
FEE TRANSMITTAL	Filing Date	July 7, 2000						
	First Named Inventor Makoto FUN		BASHI					
For FY 2005	Examiner Name	J. Lin						
Applicant claims small entity status. See 37 CFR 1.27	Applicant claims small entity status. See 37 CFR 1.27 Art Unit							
TOTAL AMOUNT OF PAYMENT (\$) 790.00	Attorney Docket No.	. 1982-0153P						
METHOD OF PAYMENT (check all that apply)								
x Check Credit Card Money Order None Other (please identify):								
Deposit Account Deposit Account Number: 02-2448 Deposit Acc	ount Name: Birch, S	tewart, Kolasch	& Birch, LLP					
For the above-identified deposit account, the Director is		eck all that apply)						
Charge fee(s) indicated below			cept for the filing fee					
Charge any additional fee(s) or underpayment of	x Credit any over							
fee(s) under 37 CFR 1.16 and 1.17	X Orean any over	payments						
FEE CALCULATION								
1. BASIC FILING, SEARCH, AND EXAMINATION FEES								
FILING FEES SE/ Small Entity	ARCH FEES EXAMI Small Entity	NATION FEES Small Entity						
Application Type Fee (\$) Fee (\$) Fee (\$			Fees Paid (\$)					
Utility 300 150 500	250 200	100						
Design 200 100 100	50 130	65						
Plant 200 100 300	150 160	80						
Reissue 300 150 500	250 600	300						
Provisional 200 100 0	0 0	0						
2. EXCESS CLAIM FEES Small Entity								
Fee Description Fee (\$)								
Each claim over 20 (including Reissues) 50 25								
Each independent claim over 3 (including Reissues)  Multiple dependent claims			200 100 360 180					
	haid (\$)	Aultiple Depende						
<u>Total Claims</u> <u>Extra Claims</u> <u>Fee (\$)</u> <u>Fee F</u> 15 - 20 = 0 x =			ee Paid (\$)					
	<u>.</u>	<u>ee (4)</u> <u>r</u>	CC T did (4)					
Indep. Claims Extra Claims Fee (\$) Fee F	 Paid (\$)							
3 -3= 0 x =			æ					
3. APPLICATION SIZE FEE								
If the specification and drawings exceed 100 sheets of paper (excluding electronically filed sequence or computer								
listings under 37 CFR 1.52(e)), the application size fee due is \$250 (\$125 for small entity) for each additional 50 shorts or fraction thereof. See 35 U.S. C. 41(a)(1)(G) and 37 CFR 1.16(c)								
sheets or fraction thereof. See 35 U.S.C. 41(a)(1)(G) and 37 CFR 1.16(s).  Total Sheets Extra Sheets Number of each additional 50 or fraction thereof Fee (\$) Fee Paid (\$)								
Total Sheets								
4. OTHER FEE(S)  Fees Paid (\$)								
Non-English Specification, \$130 fee (no small entity discount)								
Other (e.g., late filing surcharge): 1801 Request for continued examination (RCE) (see 37 790.00								
SUBMITTED BY								
Signature #13575	Registration No. (Attorney/Agent) 32,181	Telephone	(703) 205-8000					
Name (Print/Type) Marc S. Weiner Fol	Date	June 21, 2006						

JUN 2 1 2006

AMENDMENT TRANSMITTAL LETTER					Docket No.		
Application		Filing		Examiner	1982-0153P Art Unit		
09/612,543-C		July 7,		J. Lin	1762		
Applicant(s): Makoto FUNABASHI							
Invention: METHOD FOR MANUFACTURING RADIATION IMAGE CONVERSION PANEL							
MS RCE Commissioner for P.O. Box 1450 Alexandria, VA 22: Transmitted here	313-1450	ndment in the	ahove-identif	ied application			
The fee has been				• •			
	-	CLAIM	S AS AMEN	DED			
	Claims Remaining After Amendment	Highest Number Previously Paid	Number Extra Claims Present	Rate			
Total Claims	15	- 20 =	0	x			
Independent Claims	3	- 3 =	0	×			
Multiple Depend	lent Claims (ch	eck if applicabl	e)				
Other fee (please specify): Request for continued examination (RCE) (see 37 CFR 1.114)					790.00		
TOTAL ADDIT	IONAL FEE FO	OR THIS AME	NDMENT:		790.00		
No additional fee is required for this amendment.   Small Entity							

Birch, Stewart, Kolasch & Birch, LLP MSW/GMD/mua